## Search Notes

## \*10631215\*

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/631,215	PIQUE ET AL.	
Examiner	Art Unit	
Richard Bueker	1763	

	SEARCHED					
Class	Subclass	Date	Examiner			
118	722; 726	3/7/2005	RRB			
above	updated	8/1/2005	RRB			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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